Power MOSFET 40 V, 0.63 mΩ, 433 A, Single N–Channel

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- Wettable Flank Plated for Enhanced Optical Inspection
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

, ,						
Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	40	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain	Steady	T _C = 25°C	۱ _D	433	А	
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		306		
Power Dissipation	State	$T_{C} = 25^{\circ}C$	PD	205	W	
R _{θJC} (Note 1)		$T_{C} = 100^{\circ}C$		103		
Continuous Drain		$T_A = 25^{\circ}C$	I _D	67	А	
Current R _{θJA} (Notes 1, 2, 3)	Steady	$T_A = 100^{\circ}C$		47		
Power Dissipation	State	T _A = 25°C	PD	4.9	W	
R _{θJA} (Notes 1, 2)		$T_A = 100^{\circ}C$		2.5		
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	900	А	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C	
Source Current (Body Diode)			I _S	171	А	
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40 A)			E _{AS}	1446	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		0 1		260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.73	°C/W
Junction-to-Ambient - Steady State (Note 2)	R _{0.IA}	30.4	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

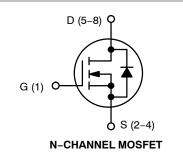
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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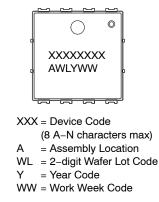
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	$0.63~\mathrm{m}\Omega @~10~\mathrm{V}$	433 A





DFNW8 TX SUFFIX CASE 507AP

MARKING DIAGRAM



ORDERING INFORMATION

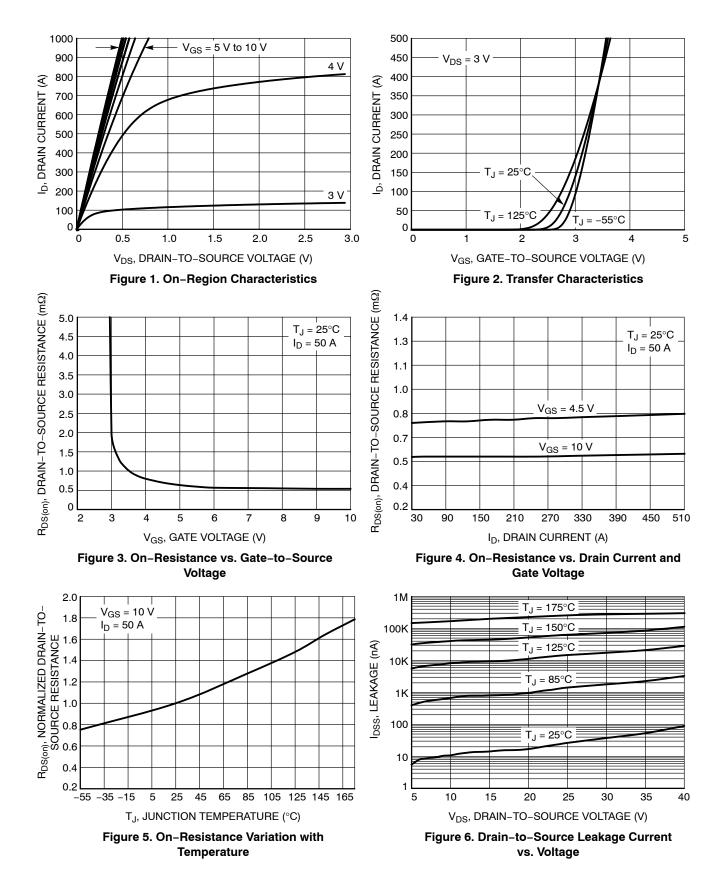
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

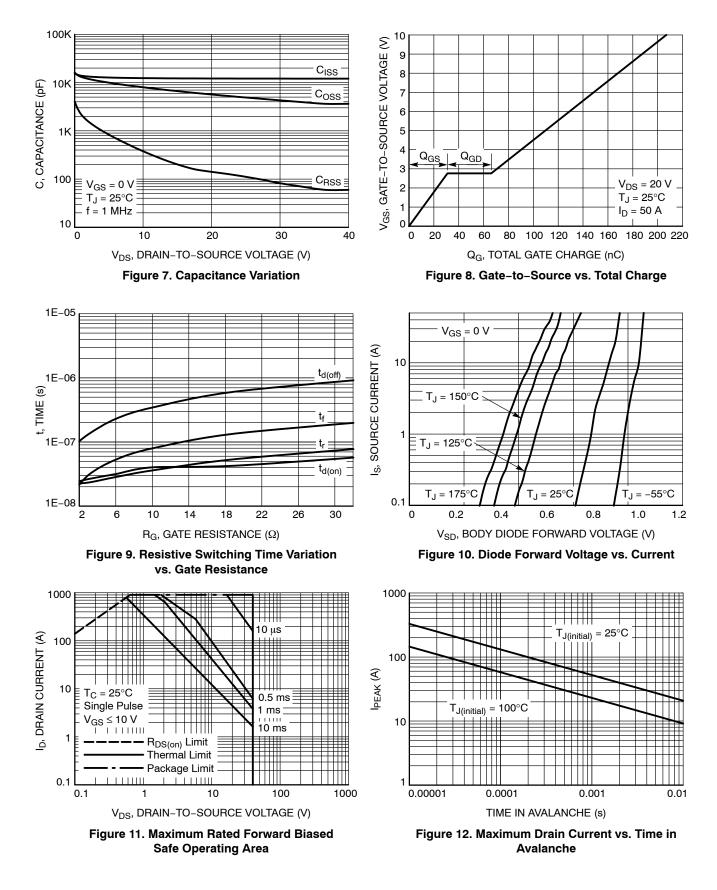
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				13.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	T _J = 25 °C			10	
		V _{DS} = 40 V	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)				-		-	-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.0		2.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.96		mV/∘C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.53	0.63	mΩ
Forward Transconductance	9 _{FS}	$V_{\rm DS} = 5$ V, I _D = 50 A			200		S
Drain-to-Source On Resistance	R _{DS(on)}	V _{DS} = 4.5 V, I _D = 50 A			0.76	0.92	mΩ
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			12238		pF
Output Capacitance	C _{OSS}				4629		
Reverse Transfer Capacitance	C _{RSS}				129		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 50 A			99		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 50 A			18		nC
Gate-to-Source Charge	Q _{GS}				31		
Gate-to-Drain Charge	Q _{GD}				32		
Plateau Voltage	V _{GP}				2.76		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			205		nC
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 20 V, I_{D} = 50 A, R_{G} = 6 Ω			31		
Rise Time	t _r				29		ns
Turn-Off Delay Time	t _{d(OFF)}				227		
Fall Time	t _f				58		
DRAIN-SOURCE DIODE CHARACTERIS	TICS				•		
Forward Diode Voltage	V _{SD}	VGS – 0 V,	$T_J = 25^{\circ}C$		0.77	1.2	
			T _J = 125°C		0.65		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 50 A			88.9		
Charge Time	ta				48.8		ns
Discharge Time	t _b				40.1		
Reverse Recovery Charge	Q _{RR}				184		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



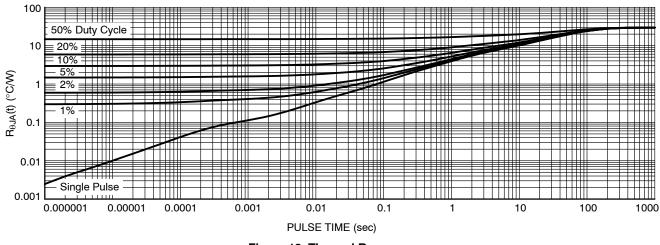


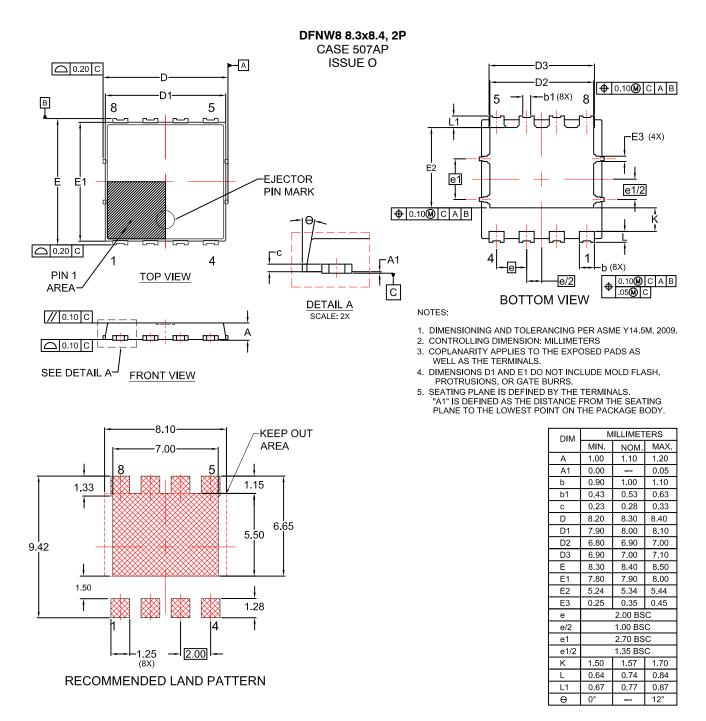
Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMTS0D7N04CLTXG	0D7N04CL	POWER 88 (Pb–Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



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